Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/580,462	LEE ET AL.	
Examiner	Art Unit	
Hoang V. Nguyen	2821	<u>.</u>

SEARCHED					
Class	Subclass	Date	Examiner		
343	703	9/7/2007	ни		
324	627	9/7/2007	HN		
324	628	9/7/2007	HN		
324	632	9/7/2007	HN		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
343	703	9/7/2007	HN		
324	627	9/7/2007	HN		
324	628	9/7/2007	HN		
324	/632	9/7/2007	· HN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
DATE	EXMR			
9/7/2007	HN			
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	DATE			